Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10757451	KOBAYASHI ET AL.
Examiner	Art Unit
Shikhman, Max	2609

SEARCHED						
Class	Subclass		Date	Examiner		
353	31		2/6/2007	Max Shikhman		
348	745		2/5/2007			

SEARCH NOTES				
Search Notes	Date	Examiner		
USPAT, USPGPUB, IBM,	2/6/2007	Max Shikhman		
IEEE, Google	2/6/2007	Max Shikhman		

,	INTERFERENCE SEAF	RCH	
Class	Subclass	Date	Examiner